

Notice of References Cited

Application/Control No.

10/669,553

Applicant(s)/Patent Under
Reexamination
KANEKO ET AL.

Examiner

JOHN R. SCHNURR

Art Unit

2623

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0162118 A1	10-2002	Levy et al.	725/110
*	B	US-2004/0123109 A1	06-2004	Choi, Yang-Ilm	713/176
*	C	US-7,120,924 B1	10-2006	Katcher et al.	725/60
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.